

MM74HC139

Dual 2-To-4 Line Decoder

General Description

This decoder utilizes advanced silicon-gate CMOS technology, and is well suited to memory address decoding or data routing applications. It possesses the high noise immunity and low power consumption usually associated with CMOS circuitry, yet has speeds comparable to low power Schottky TTL logic.

The MM54HC139/MM74HC139 contain two independent one-of-four decoders each with a single active low enable input (G1, or G2). Data on the select inputs (A1, and B1 or A2, and B2) cause one of the four normally high outputs to go low.

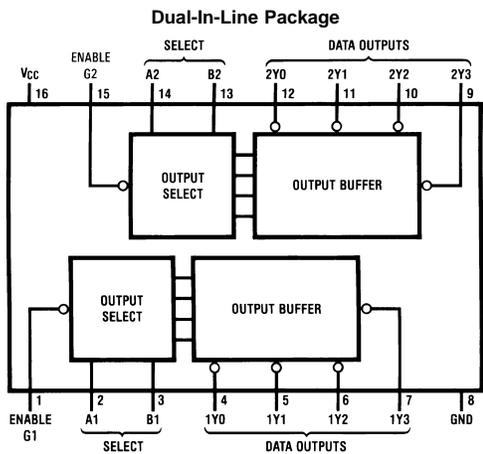
The decoder's outputs can drive 10 low power Schottky TTL equivalent loads, and are functionally as well as pin equivalent

to the 54LS139/74LS139. All inputs are protected from damage due to static discharge by diodes to V_{CC} and ground.

Features

- Typical propagation delays —
 - Select to outputs (4 delays): 18 ns
 - Select to output (5 delays): 28 ns
 - Enable to output: 20 ns
- Low power: 40 μ W quiescent supply power
- Fanout of 10 LS-TTL devices
- Input current maximum 1 μ A, typical 10 pA

Connection Diagram



Order Number MM54HC139 or MM74HC139

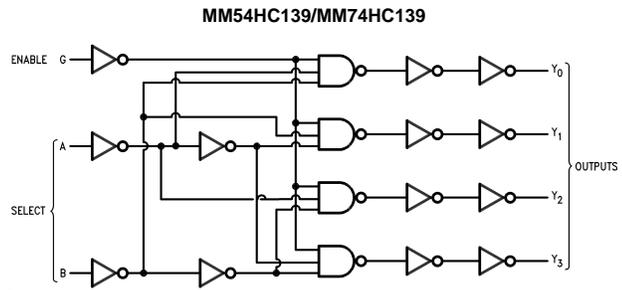
Truth Table

'HC139

| Inputs | | | Outputs | | | |
|--------|--------|---|---------|----|----|----|
| Enable | Select | | Y0 | Y1 | Y2 | Y3 |
| G | B | A | | | | |
| H | X | X | H | H | H | H |
| L | L | L | L | H | H | H |
| L | L | H | H | L | H | H |
| L | H | L | H | H | L | H |
| L | H | H | H | H | H | L |

H=high level, L=low level, X=don't care

Logic Diagram



(1 of 2)

Absolute Maximum Ratings (Notes 2, 1)

| | |
|--|-----------------------|
| Supply Voltage (V_{CC}) | -0.5 to +7.0V |
| DC Input Voltage (V_{IN}) | -1.5 to $V_{CC}+1.5V$ |
| DC Output Voltage (V_{OUT}) | -0.5 to $V_{CC}+0.5V$ |
| Clamp Diode Current (I_{IK}, I_{OK}) | ± 20 mA |
| DC Output Current, per pin (I_{OUT}) | ± 25 mA |
| DC V_{CC} or GND Current, per pin (I_{CC}) | ± 50 mA |
| Storage Temperature Range (T_{STG}) | -65°C to +150°C |
| Power Dissipation (P_D) | |
| (Note 3) | 600 mW |
| S.O. Package only | 500 mW |
| Lead Temp. (T_L) (Soldering 10 seconds) | 260°C |

Operating Conditions

| | | | |
|--|-----|----------|-------|
| Supply Voltage (V_{CC}) | Min | Max | Units |
| 2 | 2 | 6 | V |
| DC Input or Output Voltage (V_{IN}, V_{OUT}) | 0 | V_{CC} | V |
| Operating Temp. Range (T_A) | | | |
| MM74HC | -40 | +85 | °C |
| MM54HC | -55 | +125 | °C |
| Input Rise or Fall Times (t_r, t_f) | | | |
| $V_{CC}=2.0V$ | | 1000 | ns |
| $V_{CC}=4.5V$ | | 500 | ns |
| $V_{CC}=6.0V$ | | 400 | ns |

DC Electrical Characteristics (Note 4)

| Symbol | Parameter | Conditions | V_{CC} | $T_A=25^\circ C$ | | | Units | |
|----------|--|---|----------|---------------------------|-------------------|----------------------------|-----------|---------|
| | | | | 74HC | | 54HC | | |
| | | | | $T_A=-40$ to $85^\circ C$ | | $T_A=-55$ to $125^\circ C$ | | |
| | | | | Typ | Guaranteed Limits | | | |
| V_{IH} | Minimum High Level Input Voltage | | 2.0V | | 1.5 | 1.5 | 1.5 | V |
| | | | 4.5V | | 3.15 | 3.15 | 3.15 | V |
| | | | 6.0V | | 4.2 | 4.2 | 4.2 | V |
| V_{IL} | Maximum Low Level Input Voltage (Note 5) | | 2.0V | | 0.5 | 0.5 | 0.5 | V |
| | | | 4.5V | | 1.35 | 1.35 | 1.35 | V |
| | | | 6.0V | | 1.8 | 1.8 | 1.8 | V |
| V_{OH} | Minimum High Level Output Voltage | $V_{IN}=V_{IH}$ or V_{IL} $ I_{OUT} \leq 20 \mu A$ | 2.0V | 2.0 | 1.9 | 1.9 | 1.9 | V |
| | | | 4.5V | 4.5 | 4.4 | 4.4 | 4.4 | V |
| | | | 6.0V | 6.0 | 5.9 | 5.9 | 5.9 | V |
| | | $V_{IN}=V_{IH}$ or V_{IL} $ I_{OUT} \leq 4.0$ mA $ I_{OUT} \leq 5.2$ mA | 4.5V | 4.2 | 3.98 | 3.84 | 3.7 | V |
| | | | 6.0V | 5.7 | 5.48 | 5.34 | 5.2 | V |
| | | | | | | | | |
| V_{OL} | Maximum Low Level Output Voltage | $V_{IN}=V_{IH}$ or V_{IL} $ I_{OUT} \leq 20 \mu A$ | 2.0V | 0 | 0.1 | 0.1 | 0.1 | V |
| | | | 4.5V | 0 | 0.1 | 0.1 | 0.1 | V |
| | | | 6.0V | 0 | 0.1 | 0.1 | 0.1 | V |
| | | $V_{IN}=V_{IH}$ or V_{IL} $ I_{OUT} \leq 4.0$ mA $ I_{OUT} \leq 5.2$ mA | 4.5V | 0.2 | 0.26 | 0.33 | 0.4 | V |
| | | | 6.0V | 0.2 | 0.26 | 0.33 | 0.4 | V |
| | | | | | | | | |
| I_{IN} | Maximum Input Current | $V_{IN}=V_{CC}$ or GND | 6.0V | | ± 0.1 | ± 1.0 | ± 1.0 | μA |
| I_{CC} | Maximum Quiescent Supply Current | $V_{IN}=V_{CC}$ or GND $I_{OUT}=0 \mu A$ | 6.0V | | 8.0 | 80 | 160 | μA |

Note 1: Absolute Maximum Ratings are those values beyond which damage to the device may occur.

Note 2: Unless otherwise specified all voltages are referenced to ground.

Note 3: Power Dissipation temperature derating — plastic "N" package: -12 mW/°C from 65°C to 85°C; ceramic "J" package: -12 mW/°C from 100°C to 125°C.

Note 4: For a power supply of 5V $\pm 10\%$ the worst case output voltages (V_{OH} , and V_{OL}) occur for HC at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at $V_{CC}=5.5V$ and 4.5V respectively. (The V_{IH} value at 5.5V is 3.85V.) The worst case leakage current (I_{IN} , I_{CC} , and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0V values should be used.

Note 5: V_{IL} limits are currently tested at 20% of V_{CC} . The above V_{IL} specification (30% of V_{CC}) will be implemented no later than Q1, CY'89.

AC Electrical Characteristics

$V_{CC}=5V$, $T_A=25^{\circ}C$, $C_L=15\text{ pF}$, $t_r=t_f=6\text{ ns}$

| Symbol | Parameter | Conditions | Typ | Guaranteed Limit | Units |
|-----------------------|---|------------|-----|------------------|-------|
| t_{PHL} , t_{PLH} | Maximum Propagation Delay, Binary Select to any Output 4 levels of delay | | 18 | 30 | ns |
| t_{PHL} , t_{PLH} | Maximum Propagation Delay, Binary Select to any Output 5 levels of delay | | 28 | 38 | ns |
| t_{PHL} , t_{PLH} | Maximum Propagation Delay, Enable to any Output | | 19 | 30 | ns |

AC Electrical Characteristics

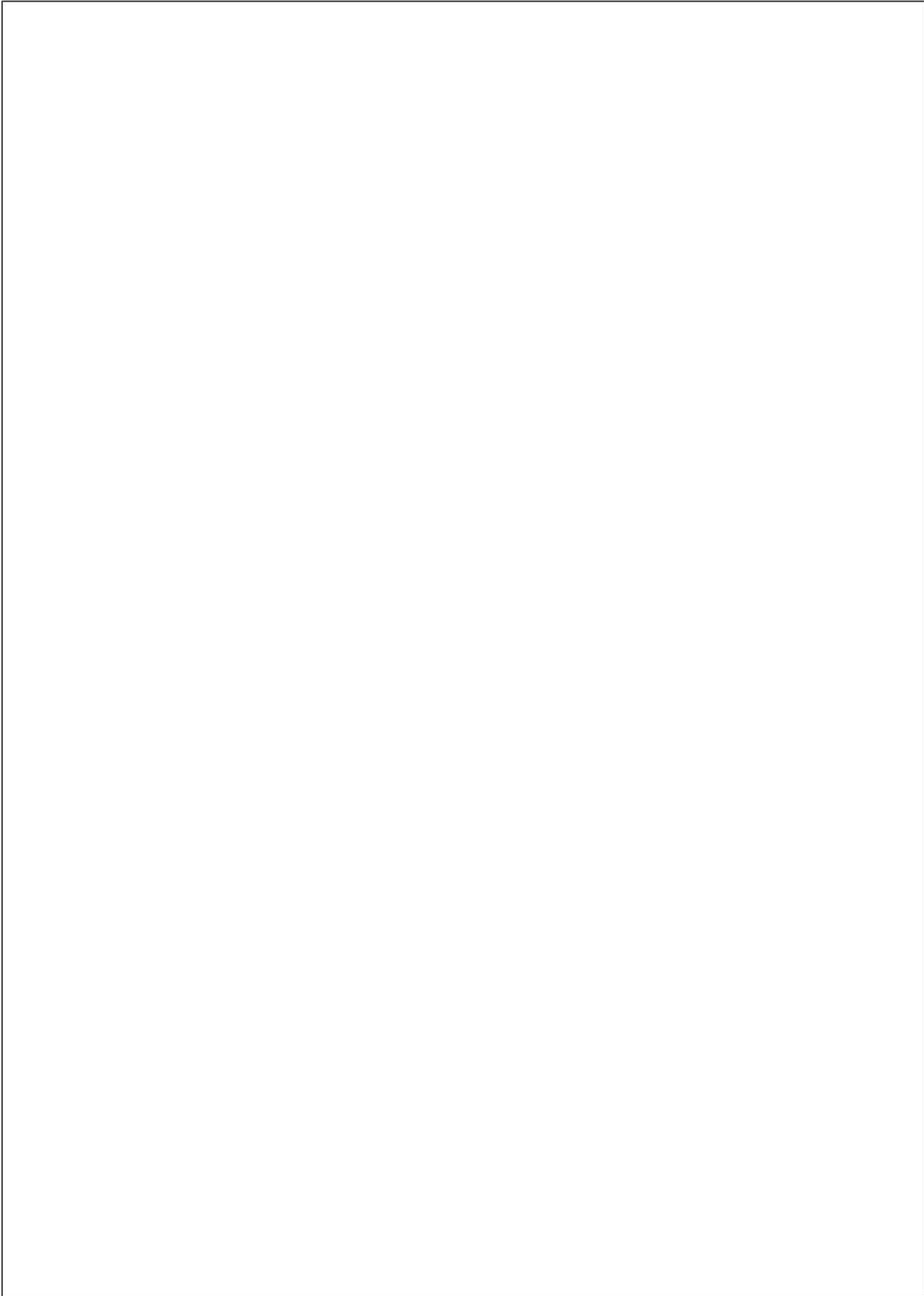
$C_L=50\text{ pF}$, $t_r=t_f=6\text{ ns}$ (unless otherwise specified)

| Symbol | Parameter | Conditions | V_{CC} | $T_A=25^{\circ}C$ | | 74HC $T_A=-40\text{ to }85^{\circ}C$ | | 54HC $T_A=-55\text{ to }125^{\circ}C$ | | Units |
|-----------------------|---|------------|----------|-------------------|-------------------|---|--|--|--|-------|
| | | | | Typ | Guaranteed Limits | | | | | |
| t_{PHL} , t_{PLH} | Maximum Propagation Delay Binary Select to any Output 4 levels of delay | (Note 7) | 2.0V | 110 | 175 | 219 | | 254 | | ns |
| | | | 4.5V | 22 | 35 | 44 | | 51 | | ns |
| | | | 6.0V | 18 | 30 | 38 | | 44 | | ns |
| t_{PHL} , t_{PLH} | Maximum Propagation Delay Binary Select to any Output 5 levels of delay | (Note 8) | 2.0V | 165 | 220 | 275 | | 320 | | ns |
| | | | 4.5V | 33 | 44 | 55 | | 64 | | ns |
| | | | 6.0V | 28 | 38 | 47 | | 54 | | ns |
| t_{PHL} , t_{PLH} | Maximum Propagation Delay Enable to any Output | | 2.0V | 115 | 175 | 219 | | 254 | | ns |
| | | | 4.5V | 23 | 35 | 44 | | 51 | | ns |
| | | | 6.0V | 19 | 30 | 38 | | 44 | | ns |
| t_{TLH} , t_{TLH} | Maximum Output Rise and Fall Time | | 2.0V | 30 | 75 | 95 | | 110 | | ns |
| | | | 4.5V | 8 | 15 | 19 | | 22 | | ns |
| | | | 6.0V | 7 | 13 | 16 | | 19 | | ns |
| C_{IN} | Maximum Input Capacitance | | | 3 | 10 | 10 | | 10 | | pF |
| C_{PD} | Power Dissipation Capacitance (Note 6) | (Note 6) | | 75 | | | | | | pF |

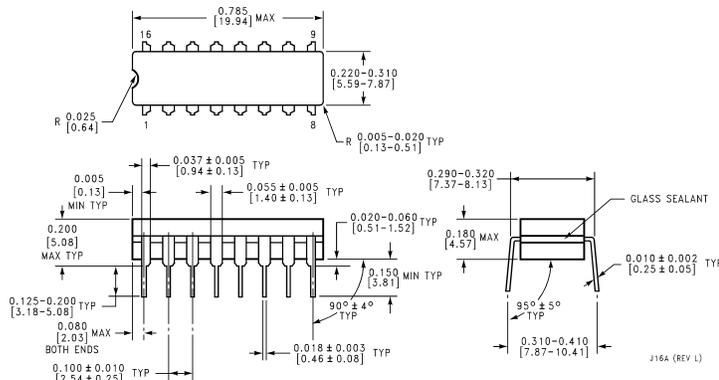
Note 6: C_{PD} determines the no load dynamic power consumption, $P_D=C_{PD} V_{CC}^2 f+I_{CC} V_{CC}$, and the no load dynamic current consumption, $I_S=C_{PD} V_{CC} f+I_{CC}$.

Note 7: 4 levels of delay are A to Y1, Y3 and B to Y2, Y3.

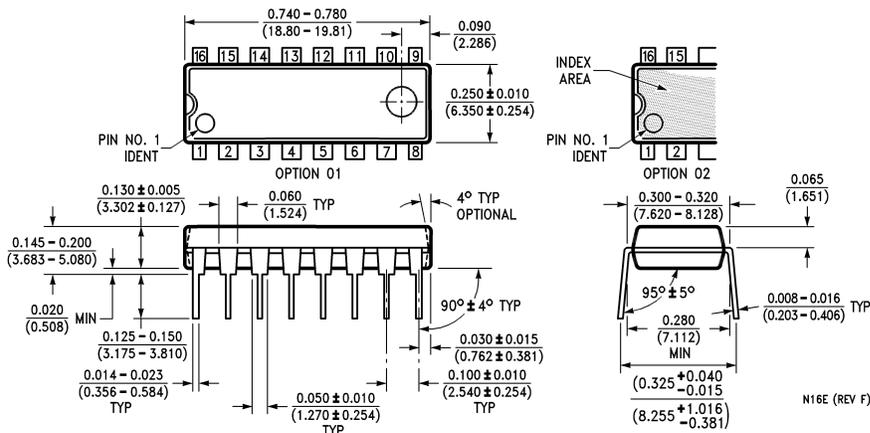
Note 8: 5 levels of delay are A to Y0, Y2 and B to Y0, Y1.



Physical Dimensions inches (millimeters) unless otherwise noted



Order Number MM54HC139J or MM74HC139J
Package J16A



Order Number MM74HC139N
Package N16E

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